

5035 Series

☑ CH5035-R433M75K-NT





X Application & Features

- RF,Wireless
- Automotive Equipment at Other
- ■5.0×3.5×1.4mm Metal Package
- This specification shall cover the characteristics of 1-port SAW resonator with 433.920M used for remote-control security.

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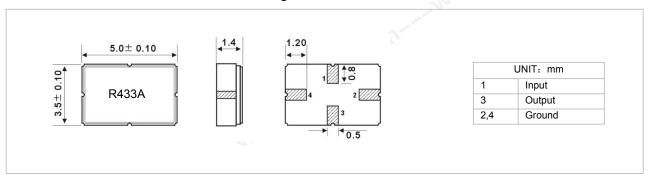
X Maximum Rating

Rating	Value	Unit	
CW RF power dissipation	P	0	dBm
DC voltage between any terminals	V _{DC}	±30	V
Operating temperature range	T _A	-40 ~ +85	°C
Storage temperature range	T _{stg}	-40 ~ +85	°C

X Electronic Characteristics

Characteristic		Sym	Minimum	Typical	Maximum	Unit	
Center Frequency (+25℃)	Absolute Frequency	fc	433.845	433.920	433.995	MHz	
	Tolerance from 433.920 MHz	Δf_C		±75		kHz	
Insertion Loss		1L		1.5	2.5	dB	
Quality Factor	Unloaded Q	Qu	8.000	12.800			
	50 Ω Loaded Q	QL	1000	2.000			
Temperature Stability	Turnover Temperature	T ₀	10	25	40	$^{\circ}\!\mathbb{C}$	
	Turnover Frequency	f ₀		fo±2.7		kHz	
	Frequency Temperature Coefficient	FTC		0.032		ppm/℃²	
Frequency Aging Absolute Value during the First Year		f _A		≤10		ppm/yr	
DC Insulation Resistance Between Any Two Terminals			1.0			MΩ	
RF Equivalent RLC Model	Motional Resistance	R _M		17.5	26	Ω	
	Motional Inductance	L _M		81.06	100	μΗ	
	Motional Capacitance	См		1.6596		pF	
	Shunt Static Capacitance	C ₀	1.7	1.96	2.3	pF	
Mechanical I	Dimensions and Marking			Walnuty .			

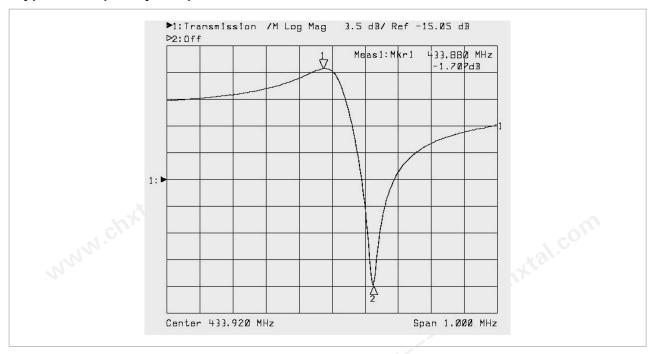
X Mechanical Dimensions and Marking



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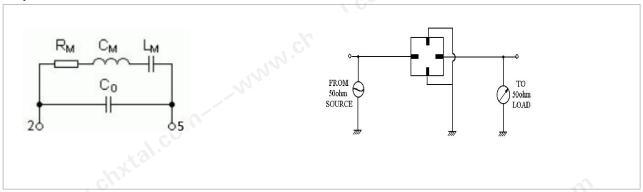


X Typical Frequency Response

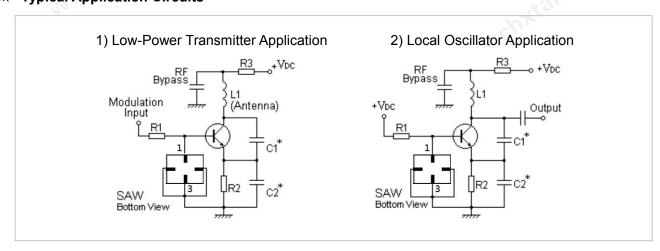


X Equivalent LC Model

X Test Circuit



X Typical Application Circuits



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X Environment Characteristic

1 Thermal Shock:

The components shall remain within the electrical specifications after being kept at the condition of heat cycle conditions: TA=-40 $^{\circ}$ ±3 $^{\circ}$, TB=85 $^{\circ}$ ±2 $^{\circ}$, t1=t2=30min, switch time≤3min& cycle time: 100 times, recovery time: 2h±0.5h.

2 Resistance to solder heat

Submerge the device terminals into the solder bath at 260 $^{\circ}$ C ± 5 $^{\circ}$ C for 10 ± 1 sec. Then release the device into the room conditions for 4 hours. It shall meet the specifications in 2.2.

3 Solder ability

Submerge the device terminals into the solder bath at $245\,^{\circ}$ C $\pm 5\,^{\circ}$ C for 5s, More than 95% area of the soldering pad must be covered with new solder. It shall meet the specifications in 2.2

4 The Temperature Storage:

- 4.1 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the $85\%\pm2\%$ for 500h, recovery time : $2h\pm0.5h$.
- 4.2 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the $-40\%\pm3\%$ for 500h, recovery time: $2h\pm0.5h$.

5 Humidity test:

The components shall remain within the electrical specifications after being kept at the condition of ambient temperature $60\,^{\circ}\text{C}\pm2\,^{\circ}\text{C}$, and 90~96% RH for 500h.

6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m for 3 times. The resonator shall fulfill the specifications in 2.2.

7 Vibration

Subject the device to the vibration for 2 hour each in X, Y and Z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The resonator shall fulfill the specifications in 2.2.

X Remark

1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.